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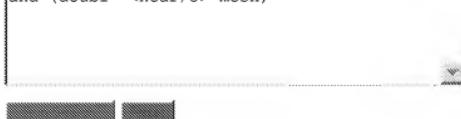

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((conformal\* or texture) <near/5> map\*)  
 and (doubl\* <near/3> mesh)



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